EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	(gate and source and (field near plate) and segment and capacitor and "gate-to-drain" and "drain-to-source" and capacitance).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/21 14:41
S1	2	"6100571".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/07 20:23
S2	3	"6614088".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/07 20:25
S3	2	"6051895".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/07 20:28
S4	11	("20020033508" | "20020079521" | "6051895" | "6100571" | "6614088").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/14 18:47
S5	302	257/312	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/14 18:50
S6	306	257/488	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/14 19:14
S7	2	("5382825").PN. OR ("6603185").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:21

S8	10	("3890698" | "4157563" | "4947232").PN. OR ("5382825").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:23
S9	8	("4047199" | "5399886" | "5872369").PN. OR ("6100571").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:27
S10	4305	field adj plate	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:33
S11	1401	S10 and (field near2 effect)	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:34
S12	156	S11 and (dynamic and control)	US-PGPUB; USPAT; USOCR	OR	OFF	2008/02/14 19:35
S13	1	"11608054"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/15 10:48
S14	1	"10572924"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/15 14:49
S15	2	("5382825").PN. OR ("6603185").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/15 16:13
S16	7	("20020033508" | "20020043699" | "20020079521" | "5973341" | "6051895" | "6051895" | "6100571" | "6100571" | "6614088"). PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/15 16:17
S17	1	"10572924"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/15 16:30
S18	36	(field near plate) and ((field near effect near transistor) or FET) and dynamic$4 and capacitance and (gate near drain) and (drain near source)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/15 16:41

S19	23	S18 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/15 16:44
S20	86	(field near plate near device) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/15 16:47
S21	2	("5382825").PN. OR ("6603185").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 12:11
S22	11	("4947232" | "4958210" | "5204545").PN. OR ("5434445").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 12:30
S23	2	("5382825").PN. OR ("6603185").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 12:36
S24	16	("4290077" | "4614959" | "4811075" | "4926243" | "5236100" | "5500387" | "5880497" | "5881657" | "6180948" | "6310374" | "6376691" | "6492689" | "6596575" | "6603185" | "6628645").PN. OR ("6989566").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 12:46
S25	11	("4792840" | "5053743" | "5063307" | "5477175" | "5498899" | "6023092" | "6222247" | "6356464" | "6509784" | "6680515" | "6989566").PN. OR ("7306999").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 12:46
S26	4551	field adj plate	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 13:00
S27	1510	S26 and (field near2 effect)	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 13:00
S28	271	S27 and (gate same drain same source same capacitance)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:00
S29	161	S28 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/16 13:01

S30	0	("field effect transistor" or FET) and "field near plate" and "gate to drain" and "drain to source" and capacitance and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/16 13:12
S31	0	("field effect transistor" or FET) and "field near plate" and "gate to drain" and "drain to source" and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/16 13:13
S32	0	("field effect transistor" or FET) and "field near plate" and "gate to drain" and "drain to source" and capacitance and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:13
S33	0	("field effect transistor" or FET) and "gate to drain" and "drain to source" and capacitance and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:14
S34	311	("field effect transistor" or FET) and (gate same drain same source) and capacitance and "field plate" and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:15
S35	177	S34 not S29	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:16
S36	111	S27 and ("field plate" same connect same gate same source)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:22
S37	65	S36 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/16 13:22

S38	0	257/E29.317 and (field near plate) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:28
S39	0	257/E29.317 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:28
S40	26	257/E29.317.ccls. and (field near plate) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/16 13:28
S41	249	257/488.ccls. and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/16 13:31
S42	8	("4290077" | "4811075" | "5003372" | "6190948" | "6310374").PN. OR ("6617652").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 13:40
S43	11	("5031021" | "5270568" | "5378912" | "5438220" | "5985708").PN. OR ("6307232").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 13:52
S44	4	("4292642" | "4766474" | "6246101" | "6307232").PN. OR ("7122875").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 14:01
S45	10	("5804864" | "5939755" | "6011297" | "6051868").PN. OR ("6246101").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 14:08
S46	10	("5804864" | "5939755" | "6011297" | "6051868").PN. OR ("6246101").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/16 14:09

S47	17	("3922708" | "4782460" | "4823173" | "4825278" | "4926243" | "4947232" | "5040045" | "5043781" | "5264719" | "5329155" | "5466959" | "5466963" | "5650645" | "5932892" | "6110804").PN. OR ("6614088").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/17 17:21
S48	38	("4006383" | "4528480" | "4601097" | "4737684" | "4766474" | "4876212" | "4908328" | "4926243" | "4983880" | "5032531" | "5056895" | "5057450" | "5095248" | "5118987" | "5132816" | "5189500" | "5198721" | "5233459" | "5258320" | "5308779" | "5309060" | "5563427" | "5736752").PN. OR ("5932892").URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/09/17 17:36
S49	1669	MOSFET and ((field near plate) or (guard near ring) or (field near guard) or (field near ring)) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/17 18:03
S50	600	S49 and capacitance	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/17 18:04
S51	551	S50 and (gate and source and drain)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/17 18:05
S52	218	S50 and (gate and source and drain) and (gate near drain) and (drain near source)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/17 18:05
S53	1669	MOSFET and ((field near plate) or (guard near ring) or (field near guard) or (field near ring)) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:20

S54	600	S53 and capacitance	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:20
S55	218	S54 and (gate and source and drain) and (gate near drain) and (drain near source)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:20
S56	218	S55 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/09/18 09:20
S57	218	S55 and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:20
S58	0	S53 and ((("gate to drain" "drain to gate") and ("gate to source" "source to gate")) same capacitance) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:31
S59	0	((("gate to drain" "drain to gate") and ("gate to source" "source to gate")) same capacitance) and @ad<"20030923"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/09/18 09:32

9/21/2008 3:24:11 PM
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